

**Table I-9 to Subpart I of Part 98—Methods and Procedures for Conducting Emissions Tests for Stack Systems**

<b>For each stack system for which you use the “stack test method” to calculate annual emissions...</b>	<b>You must...</b>	<b>Using...</b>
For each fluorinated GHG	Measure the concentration in the stack system.	Method 320 at 40 CFR part 63, appendix A or ASTM D6348-03 <sup>a</sup> (incorporated by reference, see § 98.7). Conduct the test run for a minimum of 8 hours for each stack system.
	Select sampling port locations and the number of traverse points.	Method 1 or 1A at 40 CFR part 60, appendix A-1.
	Determine gas velocity and volumetric flow rate.	Method 2, 2A, 2C, 2D, 2F, or 2G at 40 CFR part 60, appendix A-1 and A-2.
	Determine gas molecular weight.	Method 3, 3A, or 3B at 40 CFR part 60, appendix A-2 using the same sampling site and time as fluorinated GHG sampling.
	Measure gas moisture content.	Method 4 at 40 CFR part 60, appendix A-3, or using FTIR <sup>b</sup> .

<sup>a</sup> Reporters may use ASTM D6348-03 (incorporated by reference, see § 98.7) as an alternative to Method 320 at 40 CFR part 63, appendix A, with the following additional requirements: (1) The test plan preparation and implementation in the Annexes to ASTM D6348-03, Sections A1 through A8 are mandatory; and (2) In ASTM D6348-03 Annex A5 (Analyte Spiking Technique), the percent recovery (%R) must be determined for each target analyte (Equation A5.5). The reporter must also follow Section 4.1 of ASTM D6348-03 to ensure F-GHG remain in the gas phase. In order for the test data to be acceptable for a compound, the percent recovery must be between 70 and 130 percent. If the percent recovery does not meet this criterion for a target compound, the test data are not acceptable for that compound and the test must be repeated for that analyte (i.e., the sampling and/or analytical procedure should be adjusted before a retest). The percent recovery value for each compound must be reported in the test report, required under 40 CFR 98.94(j)(4), and all field measurements must be corrected with the calculated percent recovery value for that compound by using the following equation: Reported Result = Measured Concentration in the stack x (100/% R).

<sup>b</sup> Extractive FTIR is an acceptable method, in lieu of Method 4 at 40 CFR part 60 appendix A, of determining the volumetric concentrations of moisture in semiconductor stack gas streams. The spectral calibrations employed should bracket the anticipated range of optical depths (H<sub>2</sub>O concentration in parts per million multiplied by FTIR sample cell path length) measured in the field for moisture saturated (relative humidity approximately 100 percent) air streams at temperatures characterized via Method 2 at 40 CFR part 60 appendix A, within the stack. The HITRAN molecular spectroscopic database is an